## Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/780,276	TILKE ET AL.	
Examiner	Art Unit	
Thien F. Tran	2811	

SEARCHED						
Class	Subclass	Date	Examiner			
438	202-205 309, 313 322, 323	8/3/2005	TT			
438	340	8/3/2005	π			
257	552-555	8/3/2005	тт			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
438	202-205	8/3/2005	π		
438	309, 313	8/3/2005	π		
438	322, 323	8/3/2005	Π		
438/340		8/3/2005	π		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Interference Search History Printout	8/3/2005	π		
EAST .	8/3/2005	π		